

## PERRY JOHNSON LABORATORY ACCREDITATION, INC.

# Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

## A1 Calibration Laboratory S.A.

TERRUM 25 Condominium, Rio Segundo, Alajuela, Costa Rica

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

## ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

## Chemical, Dimensional, Electrical, Mass (Weighing Devices, Individual Weight), Mechanical, Thermodynamic, Time & Frequency Calibrations Thermo Hygrometer, and RPM Digital Measurement Instrument (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Tracy Szerszen	Initial Accreditation Date:	Issue .	Date:	Expiration Date:
President	April 9, 2008	October 04, 2022		December 31, 2024
Perry Johnson Laboratory	Accreditatio	on No:	Certific	cate No:
Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325	59381		L22-6	653
Troy, Michigan 48084				

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: <u>www.pjlabs.com</u>



A1 Calibration Laboratory S.A. TERRUM 25 Condominium, Rio Segunda, Alajuela, Costa Rica Contact Name: Felix Hernandez Phone: 506-2440-4010

#### Accreditation is granted to the facility to perform the following calibrations:

Chemical			
MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
pH Meters <sup>FO</sup>	Up to 14 pH	0.03 pH	Buffers Solutions
			Method I-30

#### Dimensional

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Caliper <sup>FO</sup>	Up to 600 mm	$(0.007 \text{ L} + 6) \mu\text{m}$	Gage Blocks
Micrometer <sup>FO</sup> (inside)	Up to 305 mm	$(0.007 \text{ L} + 6) \mu\text{m}$	Method I-03
Micrometer <sup>FO</sup> (outside)	Up to 400 mm	(0.007 L + 6) μm	Method I-09 Method I-18
Depth Micrometer <sup>FO</sup>	Up to 150 mm	(0.007 L + 6) μm	
Dial Indicator <sup>FO</sup>	Up to 50 mm	$(0.007 L + 6) \mu m$	Gage Blocks Method I-02
Steel Rule <sup>F</sup>	Up to 1 000 mm	0.06 mm	Gage Block Portable microscope OMAX M51B Method I-01
Pin Gages <sup>F</sup>	Up to 25.4 mm	0.002 mm	Laser Micrometer Method I-04
Measuring Tape <sup>F</sup>	Up to 12 000 mm	0.8 mm	Standard Steel Rule Method I-01
Protractor <sup>FO</sup>	0° to 90°	0.1 °	Angle Gage Blocks Method I-12 Method -35



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Electrical	-		
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Hypot Tester <sup>FO</sup>	100 V to 9 000 V	$280 \ \mu V/V + 15 \ mV$	Vitrek 4700
			Method I-45
pH Meters <sup>FO</sup>	-2 000 mV to 2 000 mV	0.3 mV	Fluke 753
			Method I-11
	15 °C to 40 °C	0.5 °C	Fluke 753/K
			Thermocouple
Temperature Calibration,	0 °C to 400 °C	0.7 °C	Process Calibrator 753
Indication and Control			8.5 DMM 8104
Equipment used with			Method I-14
Thermocouple Type T <sup>FO</sup>			Method I-20
Temperature Calibration,	50 °C to 1 700 °C	1.2 °C	Method I-51
Indication and Control			
Equipment used with			
Thermocouple Type R <sup>FO</sup>			
Temperature Calibration,	-210 °C to 750 °C	0.5 °C	
Indication and Control			
Equipment used with			
Thermocouple Type J <sup>FO</sup>			
Temperature Calibration,	-140 °C to 1 340 °C	0.4 °C	
Indication and Control			
Equipment used with			
Thermocouple Type K <sup>FO</sup>			
Temperature Calibration	-200 °C to 800 °C	0.23 °C	Process Calibrator 753
Indication & Control			Method I-14
Equipment used RTD			Method I-20
Type Pt 385, 100 $\Omega^{FO}$			Method I-51
Temperature Calibration	-200 °C to 630 °C	0.12 °C	
Indication & Control			
Equipment used RTD			
Type Pt 3926, 100 $Ω^{FO}$			



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Electrical			
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Temperature Calibration	-200 °C to 360 °C	0.25 °C	Process Calibrator 753
Indication & Control			Method I-14
Equipment used RTD			Method I-20
Type Pt 3916, 100 Ω <sup>FO</sup>			Method I-51
Temperature Calibration	-200 °C to 630 °C	0.16 °C	
Indication & Control			
Equipment used RTD			
Type Pt 385, 200 Ω <sup>FO</sup>			
Temperature Calibration	-200 °C to 630 °C	0.12 °C	
Indication & Control			
Equipment used RTD			
Type Pt 385, 500 Ω <sup>FO</sup>			
Temperature Calibration	-200 °C to 630 °C	0.23 °C	
Indication & Control			
Equipment used RTD			
Type Pt 385, 1000 Ω <sup>FO</sup>			
Temperature Calibration	-200 °C to 260 °C	0.14 °C	
Indication & Control			
Equipment used RTD			
Type Pt Ni 672, 120 $\Omega^{FO}$	$\mathcal{C}$		
Temperature Calibration	-100 °C to 260 °C	0.3 °C	
Indication & Control			
Equipment used RTD			
Type Cu 427, 10 Ω <sup>FO</sup>			
Temperature Calibration	-200 °C to 630 °C	0.5 °C	
Indication & Control			
Equipment used RTD			
Type Pt 3926, 100 Ω <sup>FO</sup>			
Temperature Calibration	-200 °C to 800 °C	0.8 °C	
Indication & Control			
Equipment used RTD			
Type Pt 385, 100 Ω <sup>FO</sup>			
Temperature Calibration	-200 °C to 630 °C	0.8 °C	
Indication & Control			
Equipment used RTD			
Type Pt 385, 200 Ω <sup>FO</sup>			
Temperature Calibration	-200 °C to 630 °C	0.8 °C	
Indication & Control			
Equipment used RTD			
Type Pt 385, 500 Ω <sup>FO</sup>			



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MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS	CALIBRATION AND MEASUREMENT	CALIBRATION EQUIPMENT
	APPROPRIATE	AS AN UNCERTAINTY (±)	STANDARDS USED
Equipment to Output DC	0 mV to 100 mV	$5.8\ \mu V/V + 0.9\ \mu V$	8.5 DMM 8104
Voltage <sup>FO</sup>	100 mV to 1 V	$4.6 \mu V/V + 2.5 \mu V$	Method I-11 Method I-10
	1 V to 10 V	$4.8 \ \mu V/V + 4.5 \mu V$	Method I-38
	10 V to 100 V	$8.5 \ \mu V/V + 72 \ \mu V$	
	100 V to 1 000 V	$25 \ \mu V/V + 250 \ \mu V$	
Equipment to Output AC V	oltage at the listed Frequen	cies <sup>FO</sup>	
10 Hz to 40 Hz	0 mV to 100 mV	$86 \ \mu V/V + 99 \ \mu V$	
40 Hz to 200 Hz	0 mV to 100 mV	$86 \mu V/V + 45 \mu V$	
200 Hz to 2 kHz	0 mV to 100 mV	$86 \mu V/V + 38 \mu V$	
2 kHz to 20 kHz	0 mV to 100 mV	$86\mu V/V + 53\mu V$	
20 kHz to 100 kHz	0 mV to 100 mV	$86 \mu V/V + 160 \mu V$	
Equipment to Output AC V	oltage at the listed Frequen	cies <sup>FO</sup>	
10 Hz to 40 Hz	100 mV to 1 V	92 $\mu V/V + 50 \mu V$	
40 Hz to 200 Hz	100 mV to 1 V	$92 \ \mu V/V + 31 \ \mu V$	
200 Hz to 2 kHz	100 mV to 1 V	$170 \ \mu V/V + 31 \ \mu V$	
2 kHz to 20 kHz	100 mV to 1 V	$350 \mu V/V + 31 \mu V$	
20 kHz to 100 kHz	100 mV to 1 V	$930 \mu V/V + 31 \mu V$	
100 kHz to 1 MHz	100 mV to 1 V	$3.5 \text{ mV/V} + 120 \mu \text{V}$	
Equipment to Output AC V	oltage at the listed Frequen	cies <sup>FO</sup>	
10 Hz to 40 Hz	1 V to 10 V	92 $\mu$ V/V + 50 $\mu$ V	
40 Hz to 200 Hz	1 V to 10 V	92 $\mu$ V/V + 31 $\mu$ V	
200 Hz to 2 kHz	1 V to 10 V	$170 \ \mu V/V + 31 \ \mu V$	
2 kHz to 20 kHz	1 V to 10 V	$350 \ \mu V/V + 31 \ \mu V$	
20 kHz to 100 kHz	1 V to 10 V	$930 \ \mu V/V + 31 \ \mu V$	
100 kHz to 200 kHz	1 V to 10 V	$3.5 \text{ mV/V} + 120 \mu \text{V}$	
Equipment to Output AC V	oltage at the listed Frequer	ncies <sup>FO</sup>	
10 Hz to 40 Hz	10 V to 100 V	$450 \ \mu V/V + 2.7 \ \overline{mV}$	
40 Hz to 200 Hz	10 V to 100 V	$450 \ \mu V/V + 2.7 \ mV$	
200 Hz to 2 kHz	10 V to 100 V	$450 \ \mu V/V + 2.7 \ \overline{mV}$	
2 kHz to 20 kHz	10 V to 100 V	$560 \mu V/V + 2.7 mV$	
20 kHz to 50 kHz	10 V to 100 V	1.5  mV/V + 2.7  mV	



A1 Calibration Laboratory S.A.

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MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Output AC V	oltage at the listed Frequer	ncies <sup>FO</sup>	8.5 DMM 8104
10 Hz to 40 Hz	100 V to 1 000 V	$450 \ \mu V/V + 2.7 \ mV$	Method I-11
40 Hz to 200 Hz	100 V to 1 000 V	$450 \ \mu V/V + 2.7 \ mV$	Method I-19 Method I-38
200 Hz to 2 kHz	100 V to 1 000 V	$560 \ \mu V/V + 2.7 \ mV$	
2 kHz to 20 kHz	100 V to 1 000 V	1.5  mV/V + 2.7  mV	
20 kHz to 50 kHz	100 V to 1 000 V	4.7  mV/V + 2.7  mV	
Equipment to Output DC	1 nA to 10 nA	$4 \mu A/A + 0.2 nA$	
Current <sup>FO</sup>	10 nA to 100 nA	8 µA/A + 0.8 nA	
	100 nA to 1 µA	12 μA/A + 1.2 nA	
	1 μA to 10 μA	24 μA/A + 1.2 nA	
	10 µA to 100 µA	$24 \mu A/A + 1 nA$	
	100 µA to 1 mA	24 μA/A + 7.1 nA	-
	1 mA to 10 mA	24 µA/A + 69 nA	-
	10 mA to 100 mA	41 μA/A + 680 nA	
	100 mA to 1 A	130 μA/A + 13 μA	-
	1 A to 10 A	130 μA/A + 26 μA	
	10 A to 30 A	130 μA/A + 80 μA	_
Equipment to Output AC C	urrent at the listed Frequen	cies <sup>FO</sup>	
10 Hz to 40 Hz	0 μA to 100 μA	0.47 % of Reading + 35 nA	-
40 Hz to 1 kHz	0 μA to 100 μA	0.18 % of Reading + 35 nA	-
1 kHz to 10 kHz	0 μA to 100 μA	0.07 % of Reading + 35 nA	-
Equipment to Output AC C	urrent at the listed Frequen	cies <sup>FO</sup>	1
10 Hz to 40 Hz	100 µA to 1 mA	0.47 % of Reading + 35 nA	
40 Hz to 1 kHz	100 µA to 1 mA	0.18 % of Reading + 35 nA	1
1 kHz to 10 kHz	100 µA to 1 mA	0.07 % of Reading + 35 nA	
Equipment to Output AC C	urrent at the listed Frequen	cies <sup>FO</sup>	1
10 Hz to 40 Hz	1 mA to 10 mA	0.18 % of Reading + 240 nA	1
40 Hz to 1 kHz	1 mA to 10 mA	0.07 % of Reading + 240 nA	1
1 kHz to 10 kHz	1 mA to 10 mA	0.035 % of Reading + 240 nA	1
Equipment to Output AC C	urrent at the listed Frequen	cies <sup>FO</sup>	1
10 Hz to 40 Hz	10 mA to 100 mA	0.18 % of Reading + 38 µA	1
40 Hz to 1 kHz	10 mA to 100 mA	0.07 % of Reading + 43 µA	1
1 kHz to 10 kHz	10 mA to 100 mA	0.035 % of Reading + 24 µA	1



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Equipment to Output AC Cu	arrent at the listed Frequence	cies <sup>FO</sup>	8.5 DMM 8104 Mathed J 11
10 Hz to 40 Hz	100 mA to 1 A	0.47 % of Reading + 240 μA	Method I-19
40 Hz to 1 kHz	100 mA to 1 A	0.19 % of Reading + 240 μA	Method I-38
1 kHz to 10 kHz	100 mA to 1 A	0.12 % of Reading + 240 μA	
Equipment to Output AC Cu	arrent at the listed Frequence	cies <sup>FO</sup>	
10 Hz to 40 Hz	1 A to 10 A	0.13 % of Reading + 150 µA	
40 Hz to 1 kHz	1 A to 10 A	0.1 % of Reading + 150 $\mu$ A	
Equipment to Output AC Cu	arrent at the listed Frequence	cies <sup>FO</sup>	
10 Hz to 40 Hz	10 A to 30 A	0.16 % of Reading + 1.5 mA	
40 Hz to 1 kHz	10 A to 30 A	0.11 % of Reading + 1.5 mA	
Equipment to Output	$0 \Omega$ to $1 \Omega$	$22 \ \mu\Omega/\Omega + 80 \ \mu\Omega$	8.5 DMM 8104
Resistance <sup>FO</sup>	1 Ω to 10 Ω	18 μΩ/Ω + 130 μΩ	Method I-37
	10 Ω to 100 Ω	$14 $ μ $\Omega/\Omega$ + 1.1 m $\Omega$	Method 1-52
	100 $\Omega$ to 1 k $\Omega$	$12 \ \mu\Omega/\Omega + 1 \ m\Omega$	
	1 kΩ to 10 kΩ	$12 $ μ $\Omega/\Omega$ + 7.4 m $\Omega$	
	10 k $\Omega$ to 100 k $\Omega$	$12 \mu \Omega / \Omega + 320 m \Omega$	
	100 k $\Omega$ to 1 M $\Omega$	18 μΩ/Ω + 7.1 Ω	
	1 M $\Omega$ to 10 M $\Omega$	59 μ $Ω/Ω + 46 $ Ω	
	$10 \text{ M}\Omega$ to $100 \text{ M}\Omega$	58 μΩ/Ω + 5.7 kΩ	
	100 M $\Omega$ to 1 G $\Omega$	58 μΩ/Ω + 0.11 ΜΩ	
	1 G $\Omega$ to 10 G $\Omega$	58 μΩ/Ω + 130 kΩ	
	$10 \text{ G}\Omega$ to $100 \text{ G}\Omega$	58 μ $\Omega/\Omega$ + 1.1 M $\Omega$	
	100 G $\Omega$ to 1 T $\Omega$	58 μΩ/Ω + 11 ΜΩ	
Equipment to Output	0 nF to 1 nF	2 % of Reading + 0.025 nF	8.5 DMM 8104
Capacitance <sup>FO</sup>	1 nF to 10 nF	1 % of Reading + 0.05 nF	Method I-11
	10 nF to 100 nF	1 % of Reading + 0.5 nF	Method I-19 Method I-38
	100 nF to 1 µF	1 % of Reading + 5 nF	Wellou 1 50
	1 μF to 10 μF	1 % of Reading + 50 nF	
	10 μF to 100 μF	1 % of Reading + 0.5 µF	
	100 µF to 1 mF	1 % of Reading + 5 $\mu$ F	
	1 mF to 10 mF	1 % of Reading + 50 $\mu$ F	
	10 mF to 100 mF	1 % of Reading + 0.2 mF	



A1 Calibration Laboratory S.A.

TERRUM 25 Condominium, Rio Segunda, Alajuela, Costa Rica Contact Name: Felix Hernandez Phone: 506-2440-4010

Mechanical			
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Pressure Gauge, Differential Pressure Indicators, Sensors and	0 kPa to 2.49 kPa	0.014 kPa	Ashcroft ATE-2/AM2-1 Transducer Method I-07 Method I-06
Transducer <sup>FO</sup>	2.49 kPa to 206 kPa	0.042 kPa	DPI 150
Vacuum Gauges, Vacuum transducers and Sensors <sup>FO</sup>	-75.8 kPa to 0 kPa	0.042 kPa	Method I-08
Aneroid Sphygmomanometer and Sphygmomanometer with Mercury <sup>FO</sup>	0 kPa to 40 kPa	0.39 kPa	DPI 104 Method I-42
Pressure Gauge, Sensors	206 kPa to 2 068 kPa	0.18 kPa	UPM Module
and Transducer <sup>FO</sup>	2 068 kPa to 3 447 kPa	0.41 kPa	Method I-07
Pressure Gauge <sup>FO</sup>	0 kPa to 6 894 kPa	0.40 kPa	5. ·
	6 894 kPa to 20 684 kPa	0.56 kPa	
	20 684 kPa to 34 473 kPa	4.5 kPa	Module 700P30 Method I-07
	34 473 kPa to 68 948 kPa	8.0 kPa	Module DP 104 Method I-07
Torque Wrench <sup>FO</sup>	0.5 Nm to 5.6 Nm	0.75 % of Reading	Transducer 2000-400-2
	3.4 Nm to 45.2 Nm	0.75 % of Reading	Method I-16
	9.0 Nm to 113 Nm	0.75 % of Reading	
	27.1 Nm to 339 Nm	0.75 % of Reading	
	271.2 Nm to 2 711 Nm	0.75 % of Reading	Transducer 2000-14-02 Method I-16
Volume Delivery	(20 to 100) µL	0.8 μL	MICROBALANCE
Instruments (Pipettes) <sup>F</sup>	(100 to 1 000) µL	1.8 μL	RADWAG BALANCES &SCALES
	(1 000 to 5 000) µL	8.9 μL	ANALITICAL BALANCE
	(5 000 to 10 000) µL	18 μL	OHAUS PA224 Method ISO 8655-6



A1 Calibration Laboratory S.A.

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Mass, Force, and V	Veighing Devices		
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Balance <sup>FO</sup>	0 g to 100 g	(0.45 + 0.003 Wt)  mg	Class F1 Weight Set
	101 g to 300 g	(0.62 + 0.003 Wt)  mg	Method I-13
	301 g to 1 000 g	(1.2 + 0.003 Wt)  mg	
	1 001 g to 2 000 g	(10 + 0.003 Wt)  mg	
	2 001 g to 10 000 g	(150 + 0.003 Wt)  mg	
	10 001 g to 30 000 g	(320 + 0.003 Wt)  mg	
	30 005 g to 60 000 g	(36 + 0.003 Wt)  g	
	60 005 g to 425 kg	(210 + 0.003Wt) g	
Weight (Mass)FO	0.5 g	0.06 mg	OIML F2, M1, M2
	1 g	0.07 mg	CEM Weight Calibration Procedure
	2 g	0.08 mg	Method 1-27
	5 g	0.1 mg	
	10 g	0.14 mg	
	20 g	0.16 mg	
	50 g	0.24 mg	
	100 g	0.46 mg	
	200 g	0.92 mg	
	500 g	2.4 mg	
	1 000 g	4.6 mg	
	2 000 g	9.6 mg	
	5 000 g	24 mg	
	10 000 g	46 mg	
	20 000 g	92 mg	
Liquid Volume Measuring	(Up to 200) mL	0.003 mL	DIGITAL BALANCE OHAUS
Devices to include	(200 to 6 000) mL	0.46 mL	PA2202 DIGITAL PALANCE
Beakers, Burets,	(6 000 to 25 000) mL	2.8 mL	METTLER TOLEDO
Erlenmeyer, Glass Micro			MS32001LE
Pipettes, Volumetric Balls,			Gravimetric Method
Imnoit Cones, Seraphin Test Measures, Gallon "to			Method CENAM Technical Guide
contain' container or			
bucket <sup>F</sup>			



## A1 Calibration Laboratory S.A.

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#### Accreditation is granted to the facility to perform the following calibrations:

Thermodynamic			
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
RTD Thermometer <sup>FO</sup>	-25 °C to 420 °C	0.08 °C	PTR 5615 / 1521
	250 °C to 420 °C	0.1 °C	Method I-14
Temperature Bath <sup>FO</sup>	-25 °C to 300 °C	0.15 °C	PTR 5613 / 1521
			Method I-14
Liquid in Glass	-25 °C to 300 °C	0.3 °C	PTR 5615 / 1521
Thermometer, Digital			Dry Well 650 S
Thermometer, Bimetallic			Liquid Bath
Thermometer <sup>FO</sup>			TE-10D
			Method I-14
			Method I-51
Oven, Freezer, Furnace,	-25 °C to 650 °C	1.7 °C	Fluke 753 / /TC type J and K /
Digital Thermometer with			Graphtec GL 220/Dry Well 650 S
thermocouple.FO			Method I-14
Digital Infrared	-25 °C to 35 °C	1.8 °C	Liquid Bath TE-10D with blackbody
Thermometer <sup>FO</sup>	35 °C to 400 °C	0.3 °C	target with TC type K
		<b>\</b>	Method I-15
Thermo Hygrometer <sup>FO</sup>	15 °C to 30 °C	0.3 °C	Standard Thermo Hygrometer 635-1
	20 % RH to 95 % RH	2.5 % RH	Method 1-42

#### Time & Frequency

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Time and Frequency Simulation <sup>FO</sup>	1 μHz to 80 MHz	3 x 10 <sup>-5</sup> Hz/Hz	Function Generator 4086 Method I-46 Method I-40 Method I-21
	0 GHz to 2.4 GHz	60 x 10 <sup>-6</sup> Hz/Hz	Frequency Counter C3100
RPM Digital Measurement Instrument <sup>FO</sup>	10 rpm to 90 000 rpm	0.05 % of Reading	Function Generator 4086 Method I-43

1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.



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- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location. Example: Outside Micrometer<sup>F</sup> would mean that the laboratory performs this calibration at its fixed location.
- 4. The presence of a superscript FO means that the laboratory performs calibration of the indicated parameter both at its fixed location and onsite at customer locations. Example: Outside Micrometer<sup>FO</sup> would mean that the laboratory performs this calibration at its fixed location and onsite at customer locations.
- 5. Measurement uncertainties obtained for calibrations performed at customer sites can be expected to be larger than the measurement uncertainties obtained at the laboratories fixed location for similar calibrations. This is due to the effects of transportation of the standards and equipment and upon environmental conditions at the customer site which are typically not controlled as closely as at the laboratories fixed location.